#17/AMOT D(NE) 4/15/02

RESPONSE UNDER 37 CFR 1.116 EXPEDITED PROCEDURE EXAMINING GROUP 2811

> PATENT APPLICATION Do. No. 5484-48

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In re application of: Byung-Sup SHIM, et al.

APR 1 2 2002

Serial No.

09/305,240

Examiner: Nadav. Ori

TECHNOLOGY CENTER 2800

Filed:

May 4, 1999

Group Art Unit: 2811

For:

OPEN DRAIN INPUT/OUTPUT STRUCTURE AND MANUFACTURING METHOD THEREOF IN SEMICONDUCTOR DEVICE

BOX AF Assistant Commissioner for Patents Washington, D.C. 20231

## ANIENDMENT AFTER FINAL REJECTION UNDER 37 CFR 1.116

Responsive to the Final Office Action, dated February 13, 2002, please amend the application as follows.

## IN THE CLAIMS

5. (Twice Amended) A pull-up transistor disposed between a Vdd terminal and an I/O pi·d of a semiconductor device comprising:

a semiconductor substrate of a first conductive-type;

a sou ce region and a drain region of a second conductive type formed in the substrate and defining between them a channel region, one of the source region and the drain region being electrically coupled to the I/O pad, the other one of the source region and the drain region being electrically coupled to the Vdd terminal;

an impurity implantation region of impurities of a second conductive-type formed in a first sector of the channel region, the first sector not reaching either one of the source region and the drain region;

the impurity implantation region of the first sector comprising a surface region operable under field effect as a depletion channel;

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we will